

Search Notes

Application/Control No.

10/576,106

Examiner

Chau N. Nguyen

Applicant(s)/Patent under
Reexamination

VAN NOTEN ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
174	77R	1/16/2008	CN
	93		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR